## Mechanical strength improvement of a soda-lime-silica glass by thermal treatment under flowing gas

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The nitridation of silicon dioxide films by Chemical Vapour Deposition (CVD) routes has been extensively studied in the recent years for its great technological interest in semiconductor science <sup>1</sup>. In contrast to SiO<sub>2</sub>, silicon nitride and silicon oxynitride films have excellent diffusion-limiting properties and therefore exhibit a protective action against corrosion, oxidation and impurity diffusion. Although nitridation is commonly used to improve the mechanical performances of iron steels <sup>2</sup>, few papers only studies nitridation of silicates glasses surfaces <sup>3</sup>.

In this study, thermal treatments of a soda-lime-silica glass under different atmospheres (air, N<sub>2</sub> and NH<sub>3</sub>) were conducted by flowing gas trough a silica tube placed into an electrical furnace. Nitrogen content gas treatments create compositional changes in the near surface: SIMS and XPS techniques revealed significant alkali depletion and a limited nitrogen penetration respectively. FTIR-reflexion spectroscopy <sup>4</sup> was used to follow the displacement of the Si-O stretching band, from 1056 cm<sup>-1</sup> to 1110 cm<sup>-1</sup>, giving evidence for compositional changes from typical soda-lime glass towards a near silica glass composition.

The hardness and the fracture toughness of glasses were measured by the indentation technique as a function of heat-treatment time and temperature. In addition, nanoindentation investigations were carried out using an atomic force microscope set-up. The fracture strength measurement was carried out using a four-point bending test.

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<sup>&</sup>lt;sup>3</sup> J. Schroeder and J.J. Jarek, Nitrogen doping of fused silica and silicate glasses: a study of transport and optical properties, JNCS **102** 191-195 (1988)

<sup>&</sup>lt;sup>4</sup> A. Agarwal, K.M. Davis and M. Tomozawa, A simple IR spectroscopic method for determining fictive temperature of silica glasses, JNCS 185 191-198 (1995)